

TECHNICAL

SPECIFICATION

-UNCI

IEC TS 62196-3-1

Edition 1.0 2020-03



Plugs, socket-outlets, vehicle connectors and vehicle inlets – Conductive charging of electric vehicles – Part 3-1: Vehicle connector, vehicle inlet and cable assembly for DC charging

intended to be used with a thermal management system



THIS PUBLICATION IS COPYRIGHT PROTECTED Copyright © 2020 IEC, Geneva, Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either IEC or IEC's member National Committee in the country of the requester. If you have any questions about IEC copyright or have an enquiry about obtaining additional rights to this publication, please contact the address below or your local IEC member National Committee for further information.

IEC Central Office 3, rue de Varembé CH-1211 Geneva 20 Switzerland

Tel.: +41 22 919 02 11 info@iec.ch www.iec.ch

About the IEC

The International Electrotechnical Commission (IEC) is the leading global organization that prepares and publishes International Standards for all electrical, electronic and related technologies.

About IEC publications

The technical content of IEC publications is kept under constant review by the IEC. Please make sure that you have the latest edition, a corrigendum or an amendment might have been published.

IEC publications search - webstore.iec.ch/advsearchform

The advanced search enables to find IEC publications by a variety of criteria (reference number, text, technical committee,...). It also gives information on projects, replaced and withdrawn publications.

IEC Just Published - webstore.iec.ch/justpublished Stay up to date on all new IEC publications. Just Published details all new publications released. Available online and once a month by email.

IEC Customer Service Centre - webstore.iec.ch/csc

If you wish to give us your feedback on this publication or need further assistance, please contact the Customer Service Centre: sales@iec.ch.

Electropedia - www.electropedia.org

The world's leading online dictionary on electrotechnology, containing more than 22 000 terminological entries in English and French, with equivalent terms in 16 additional languages. Also known as the International Electrotechnical Vocabulary (IEV) online.

IEC Glossary - std.iec.ch/glossary

67 000 electrotechnical terminology entries in English and French extracted from the Terms and Definitions clause of IEC publications issued since 2002. Some entries have been collected from earlier publications of IEC TC 37, 77, 86 and CISPR.





Edition 1.0 2020-03





Plugs, socket-outlets, vehicle connectors and vehicle inlets – Conductive charging of electric vehicles –

Part 3-1: Vehicle connector, vehicle inlet and cable assembly for DC charging intended to be used with a thermal management system

INTERNATIONAL ELECTROTECHNICAL COMMISSION

ISBN 978-2-8322-8022-5

Jene oko oz

ICS 29.120.30; 43.120

Warning! Make sure that you obtained this publication from an authorized distributor.

CONTENTS

5			
7			
8			
8			
9			
.10			
. 18			
.19			
.20			
.21			
.21			
.21			
.21			
.22			
. 22			
.22			
.22			
.22			
.25			
.25			
.26			
.26			
.26			
.26			
.26			
.26			
.31			
. 32			
.33			
. 33			
.33			
.33			
.33			
. 33			
. 33			
. 34			
.36			
.44			
.45			
.53			
Annex E (informative) Recommended data61			
.62			

Figure 101 – DC EV supply equipment with thermal sensing	17
Figure 102 – DC EV supply equipment with thermal sensing, thermal transport and thermal exchange	18
Figure A.1 – Reference device AA_0	36
Figure A.2 – Test setup AA_0	37
Figure A.3 – Test setup AA_1	38
Figure A.4 – Test setup AA_2	39
Figure A.5 – Reference device AA_1	39
Figure A.6 – Test setup AA_3	40
Figure A.7 – Reference device AA_2	41
Figure A.8 – Test setup AA_4	42
Figure A.9 – General test setup for temperature rise tests and thermal sensing device tests (configuration AA)	42
Figure A.10 – Plating of contacts for configuration AA	43
Figure C.1 – Reference device EE_0	46
Figure C.2 – Test setup EE_0	47
Figure C.3 – Test setup EE_1	
Figure C.4 – Test setup EE_2	48
Figure C.5 – Reference device EE_1	
Figure C.6 – Test setup EE_3	49
Figure C.7 – Reference device EE_2	49
Figure C.8 – Test setup EE_4	50
Figure C.9 – General test setup for temperature rise tests and thermal sensing device tests (configuration EE)	50
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE	52
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0	52 54
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0 Figure D.2 – Test setup FF_0	52 54 55
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0 Figure D.2 – Test setup FF_0 Figure D.3 – Test setup FF_1	52 54 55 55
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0 Figure D.2 – Test setup FF_0 Figure D.3 – Test setup FF_1 Figure D.4 – Test setup FF_2	52 54 55 55 56
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0 Figure D.2 – Test setup FF_0 Figure D.3 – Test setup FF_1 Figure D.4 – Test setup FF_2 Figure D.5 – Reference device FF_1	52 54 55 55 56 57
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0 Figure D.2 – Test setup FF_0 Figure D.3 – Test setup FF_1 Figure D.4 – Test setup FF_2 Figure D.5 – Reference device FF_1 Figure D.6 – Test setup FF_3	52 54 55 55 56 57 57
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0 Figure D.2 – Test setup FF_0 Figure D.3 – Test setup FF_1 Figure D.4 – Test setup FF_2 Figure D.5 – Reference device FF_1 Figure D.6 – Test setup FF_3 Figure D.7 – Reference device FF_2	52 54 55 55 56 57 57 58
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0 Figure D.2 – Test setup FF_0 Figure D.3 – Test setup FF_1 Figure D.4 – Test setup FF_2 Figure D.5 – Reference device FF_1 Figure D.6 – Test setup FF_3	52 54 55 55 56 57 57 58
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0. Figure D.2 – Test setup FF_0 Figure D.3 – Test setup FF_1 Figure D.4 – Test setup FF_2 Figure D.5 – Reference device FF_1. Figure D.6 – Test setup FF_3 Figure D.7 – Reference device FF_2. Figure D.8 – Test setup FF_4 Figure D.9 – General test setup for temperature rise tests and thermal sensing device tests (configuration FF).	52 55 55 56 57 57 58 58 58
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0 Figure D.2 – Test setup FF_0 Figure D.3 – Test setup FF_1 Figure D.4 – Test setup FF_2 Figure D.5 – Reference device FF_1 Figure D.6 – Test setup FF_3 Figure D.7 – Reference device FF_2 Figure D.8 – Test setup FF_4 Figure D.9 – General test setup for temperature rise tests and thermal sensing device	52 55 55 56 57 57 58 58 58
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0 Figure D.2 – Test setup FF_0 Figure D.3 – Test setup FF_1 Figure D.4 – Test setup FF_2 Figure D.5 – Reference device FF_1 Figure D.6 – Test setup FF_3 Figure D.7 – Reference device FF_2 Figure D.8 – Test setup FF_4 Figure D.9 – General test setup for temperature rise tests and thermal sensing device tests (configuration FF) Figure D.10 – Plating of contacts for configuration FF	52 54 55 55 57 57 58 58 58 59 60
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0. Figure D.2 – Test setup FF_0 . Figure D.3 – Test setup FF_1 . Figure D.4 – Test setup FF_2 . Figure D.5 – Reference device FF_1. Figure D.6 – Test setup FF_3 . Figure D.7 – Reference device FF_2. Figure D.8 – Test setup FF_4 . Figure D.9 – General test setup for temperature rise tests and thermal sensing device tests (configuration FF). Figure D.10 – Plating of contacts for configuration FF. Table 101 – Overview of applicable tests for different classifications of accessories	52 54 55 55 57 57 58 58 59 60
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0 Figure D.2 – Test setup FF_0 Figure D.3 – Test setup FF_1 Figure D.4 – Test setup FF_2 Figure D.5 – Reference device FF_1 Figure D.6 – Test setup FF_3 Figure D.7 – Reference device FF_2 Figure D.8 – Test setup FF_4 Figure D.9 – General test setup for temperature rise tests and thermal sensing device tests (configuration FF) Figure D.10 – Plating of contacts for configuration FF	52 54 55 55 57 57 58 58 59 60
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0 Figure D.2 – Test setup FF_0 Figure D.3 – Test setup FF_1 Figure D.4 – Test setup FF_2 Figure D.5 – Reference device FF_1 Figure D.6 – Test setup FF_3 Figure D.7 – Reference device FF_2 Figure D.8 – Test setup FF_4 Figure D.9 – General test setup for temperature rise tests and thermal sensing device tests (configuration FF) Figure D.10 – Plating of contacts for configuration FF Table 101 – Overview of applicable tests for different classifications of accessories Table 102 – Test sequence A Table 103 – Test sequence B	52 54 55 55 57 57 58 58 59 60 11 15 15
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0. Figure D.2 – Test setup FF_0 Figure D.3 – Test setup FF_1 Figure D.4 – Test setup FF_2 Figure D.5 – Reference device FF_1. Figure D.6 – Test setup FF_3 Figure D.7 – Reference device FF_2. Figure D.8 – Test setup FF_4 Figure D.9 – General test setup for temperature rise tests and thermal sensing device tests (configuration FF). Figure D.10 – Plating of contacts for configuration FF. Table 101 – Overview of applicable tests for different classifications of accessories Table 103 – Test sequence B Table 104 – Test sequence C	52 54 55 55 57 57 58 58 58 59 60 11 15 15
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0. Figure D.2 – Test setup FF_0. Figure D.3 – Test setup FF_1. Figure D.4 – Test setup FF_2. Figure D.5 – Reference device FF_1. Figure D.6 – Test setup FF_3. Figure D.7 – Reference device FF_2. Figure D.8 – Test setup FF_4. Figure D.9 – General test setup for temperature rise tests and thermal sensing device tests (configuration FF). Figure D.10 – Plating of contacts for configuration FF. Table 101 – Overview of applicable tests for different classifications of accessories Table 102 – Test sequence A. Table 103 – Test sequence B. Table 104 – Test sequence C. Table 105 – Test sequence D.	52 54 55 55 57 57 57 58 58 59 60 11 15 15 16 16
tests (configuration EE) Figure C.10 – Plating of contacts for configuration EE Figure D.1 – Reference device FF_0. Figure D.2 – Test setup FF_0 Figure D.3 – Test setup FF_1 Figure D.4 – Test setup FF_2 Figure D.5 – Reference device FF_1. Figure D.6 – Test setup FF_3 Figure D.7 – Reference device FF_2. Figure D.8 – Test setup FF_4 Figure D.9 – General test setup for temperature rise tests and thermal sensing device tests (configuration FF). Figure D.10 – Plating of contacts for configuration FF. Table 101 – Overview of applicable tests for different classifications of accessories Table 103 – Test sequence B Table 104 – Test sequence C	52 54 55 55 57 57 57 58 58 58

Table 108 – Interface overview	21
Table 109 – Short-time test currents	22
Table 110 – Properties of DC accessory contact plating for pin	25
Table 111 – Normal operation	26
Table 112 – Pull force and torque test values for cable anchorage	31
Table 113 – Impact energy for ball impact test	32
Table 114 – Mechanical load flexing test	33
Table A.1 – Maximum contact resistances and dimensions of reference device AA_0	37
Table A.2 – Dimensions for reference device conductor	43
Table C.1 – Contact resistances and dimensions of reference device EE_0	46
Table C.2 – Dimensions for reference device conductor (configuration EE)	51
Table D.1 – Contact resistances and dimensions of reference device FF_0	54
Table D.2 – Dimensions for reference device conductor (configuration FF)	59

INTERNATIONAL ELECTROTECHNICAL COMMISSION

PLUGS, SOCKET-OUTLETS, VEHICLE CONNECTORS AND VEHICLE INLETS – CONDUCTIVE CHARGING OF ELECTRIC VEHICLES –

Part 3-1: Vehicle connector, vehicle inlet and cable assembly for DC charging intended to be used with a thermal management system

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

The main task of IEC technical committees is to prepare International Standards. In exceptional circumstances, a technical committee may propose the publication of a Technical Specification when

- the required support cannot be obtained for the publication of an International Standard, despite repeated efforts, or
- the subject is still under technical development or where, for any other reason, there is the future but no immediate possibility of an agreement on an International Standard.

Technical Specifications are subject to review within three years of publication to decide whether they can be transformed into International Standards.

IEC TS 62196-3-1, which is a Technical Specification, has been prepared by subcommittee 23H: Plugs, Socket-outlets and Couplers for industrial and similar applications, and for Electric Vehicles, of IEC technical committee TC 23: Electrical accessories.

The text of this Technical Specification is based on the following documents:

Draft TS	Report on voting
23H/448/DTS	23H/460/RVDTS

Full information on the voting for the approval of this Technical Specification can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all the parts in the IEC 62196 series, published under the general title *Plugs*, *socket-outlets, vehicle connectors and vehicle inlets* – *Conductive charging of electrical vehicles*, can be found on the IEC website.

This document is to be read in conjunction with IEC 62196-1:2014 and IEC 62196-3:2014. The particular requirements in this document supplement or modify the corresponding clauses in Part 3, which, in turn, is based on Part 1. Where the text indicates an "addition" to or a "replacement" of the relevant requirement, test specification or explanation of Part 3, these changes are made to the relevant text of Part 3 or Part 1, which then becomes part of this document. Where no change is necessary, the words "Clause X of IEC 62196-3:2014 applies" are used.

Subclauses, figures, tables or notes which are additional to those in IEC 62196-3 are numbered starting from 101.

In this document, the following print types are used:

- requirements proper: in roman type;
- test specifications: in italic type;
- notes: in smaller roman type.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific document. At this date, the document will be

- transformed into an International Standard,
- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

INTRODUCTION

Responding to global challenges of CO_2 reduction and energy safety, the automobile industries have been accelerating the development and commercialization of electric vehicles (EV) and hybrid electric vehicles. In addition to the prevailing hybrid electric vehicles, battery electric vehicles including plug-in hybrid electric vehicles are going to be mass-marketed. To support the diffusion of such vehicles, this document provides the standard interface configurations of vehicle couplers and accessories to be used in conductive charging of electric vehicles, taking the most frequent charging situations into consideration.

To meet the market demand for increased electric vehicle ranges, batteries with larger capacities need to be integrated. To charge those batteries with larger capacity in similar times as existing charging times or even faster, the charging power needs to be increased. Besides increasing the charging voltage, the charging current also needs to be increased to boost the charging power. The larger charging current implies either larger conductor cross sections for the cable assembly according to existing standards or additional measures in the cable assembly.

The large conductor cross sections that are required according to the existing design requirements and test methods result in significantly thicker and heavier cable assemblies. These are difficult to handle and thus less desirable for public use. Therefore, to improve the usability of charging systems this document makes use of thermal management techniques to enhance the performance of the accessories.

This document provides definitions, requirements, and tests for EV couplers up to rated current according to IEC 62196-1, which supports backward compatibility to couplers according to IEC 62196-3:2014.

IEC 62196 is divided into several parts as follows:

- Part 1: General requirements, comprising clauses of a general character.
- Part 2: Dimensional compatibility requirements for AC pin and contact-tube accessories.
- Part 3: Dimensional compatibility requirements for DC and AC/DC pin and contact-tube vehicle couplers.
- Part 4¹: Dimensional compatibility requirements for DC pin and contact-tube accessories for Class II or Class III applications.
- Part 6²: Dimensional compatibility requirements for DC pin and contact-tube couplers for applications using a system of protective electrical separation.

¹ Under preparation.

² Under consideration.

PLUGS, SOCKET-OUTLETS, VEHICLE CONNECTORS AND VEHICLE INLETS – CONDUCTIVE CHARGING OF ELECTRIC VEHICLES –

Part 3-1: Vehicle connector, vehicle inlet and cable assembly for DC charging intended to be used with a thermal management system

1 Scope

This document applies to accessories and cable assemblies with the same configuration as specified in IEC 62196-3:2014 with rated operating voltage not exceeding 1 500 V DC and a rated current not exceeding 500 A that employ

- thermal sensing, or
- thermal transport and thermal sensing

with the system architecture described in 4.101.

These accessories and cable assemblies are intended to be used in conductive charging systems for circuits specified in IEC 61851-23.

NOTE Edition 2 of IEC 61851-23 is under development.

The accessories covered by this document are intended to be used in charging mode 4 according to IEC 61851-1. These accessories are intended to be connected to cables according to the IEC 62893 series for DC cables.

2 Normative references

Clause 2 of IEC 62196-3:2014 applies, except as follows:

Additional normative references:

IEC 60364-5-54:2011, Low-voltage electrical installations – Part 5-54: Selection and erection of electrical equipment – Earthing arrangements and protective conductors

IEC 60811-501, Electric and optical fibre cables – Test methods for non-metallic materials – Part 501: Mechanical tests – Tests for determining the mechanical properties of insulating and sheathing compounds

IEC 61851-23:—³, *Electric vehicle conductive charging system – Part 23: DC electric vehicle supply equipment*

IEC 62196-1:2014, Plugs, socket-outlets, vehicle connectors and vehicle inlets – Conductive charging of electric vehicles – Part 1: General requirements

IEC 62196-2:2016, Plugs, socket-outlets, vehicle connectors and vehicle inlets – Conductive charging of electric vehicles – Part 2: Dimensional compatibility and interchangeability requirements for AC pin and contact-tube accessories

³ Second edition under preparation. Stage at the time of publication: IEC CDV 61851-23:2020.